

Notice of References Cited	Application/Control No. 10/790,142	Applicant(s)/Patent Under Reexamination SENDAI ET AL.	
	Examiner Shun Lee	Art Unit 2884	Page 1 of 1

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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